

#### SNLS346A - AUGUST 2011 - REVISED SEPTEMBER 2011

# DS90UR903Q/DS90UR904Q 10 - 43MHz 18 Bit Color FPD-Link II Serializer and Deserializer

Check for Samples: DS90UR903Q, DS90UR904Q

# **FEATURES**

- 10 MHz to 43 MHz input PCLK support
- 210 Mbps to 903 Mbps data throughput
- Single differential pair interconnect
- Embedded clock with DC Balanced coding to support AC-coupled interconnects
- Capable to drive up to 10 meters shielded twisted-pair
- I<sup>2</sup>C compatible serial interface for device configuration
- Single hardware device addressing pin
- LOCK output reporting pin to validate link integrity
- Integrated termination resistors
- 1.8V- or 3.3V-compatible parallel bus interface
- Single power supply at 1.8V
- ISO 10605 ESD and IEC 61000-4-2 ESD

#### compliant

- Automotive grade product: AEC-Q100 Grade 2 qualified
- Temperature range -40°C to +105°C
- No reference clock required on Deserializer
- Programmable Receive Equalization
- EMI/EMC Mitigation
  - DES Programmable Spread Spectrum (SSCG) outputs
  - DES Receiver staggered outputs

# APPLICATIONS

- Automotive Display Systems
  - Central Information Displays
  - Navigation Displays
  - Rear Seat Entertainment

# DESCRIPTION

The DS90UR903Q/DS90UR904Q chipset offers a FPD-Link II interface with a high-speed forward channel for data transmission over a single differential pair. The Serializer/ Deserializer pair is targeted for direct connections between graphics host controller and displays modules. This chipset is ideally suited for driving video data to displays requiring 18-bit color depth (RGB666 + HS, VS, and DE). The serializer converts 21 bit data over a single high-speed serial stream. This single serial stream simplifies transferring a wide data bus over PCB traces and cable by eliminating the skew problems between parallel data and clock paths. This significantly saves system cost by narrowing data paths that in turn reduce PCB layers, cable width, and connector size and pins.

The Deserializer inputs provide equalization control to compensate for loss from the media over longer distances. Internal DC balanced encoding/decoding is used to support AC-Coupled interconnects.

The Serializer is offered in a 40-pin lead in LLP and Deserializer is offered in a 48-pin LLP packages.

# Typical Application Diagram

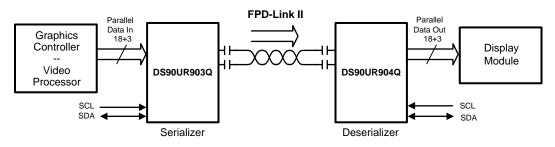


Figure 1. Typical Application Circuit

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## **Block Diagrams**

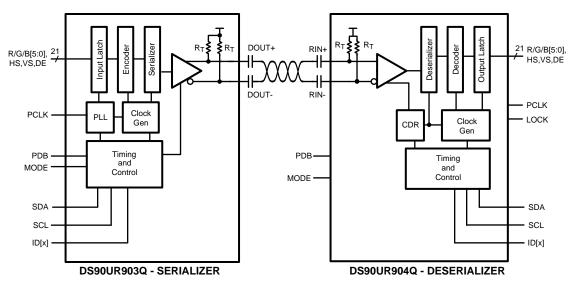


Figure 2. Block Diagram

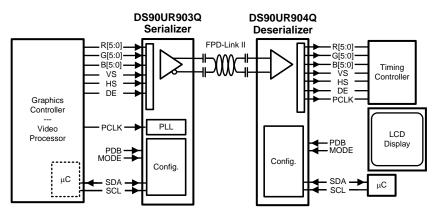
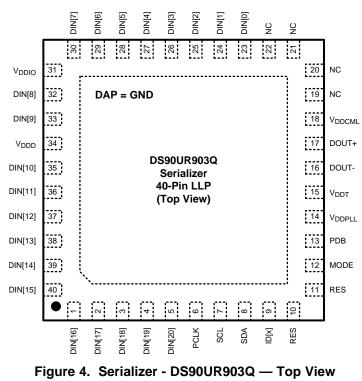


Figure 3. Application Block Diagram



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#### DS90UR903Q Pin Diagram



## **DS90UR903Q Serializer Pin Descriptions**

#### **Pin Descriptions**

Pin Name	Pin No.	I/O, Type	Description
LVCMOS PARAL	LEL INTERFACE	L	
DIN[20:0]	5, 4, 3, 2, 1, 40, 39, 38, 37, 36, 35, 33, 32, 30, 29, 28, 27, 26, 25, 24, 23	Inputs, LVCMOS w/ pull down	Parallel data inputs.
PCLK	6	Input, LVCMOS w/ pull down	Pixel Clock Input Pin. Strobe edge set by TRFB control register.
SERIAL CONTRO	DL BUS - I <sup>2</sup> C COMPA	TIBLE	
SCL	7	Input, Open Drain	Clock line for the serial control bus communication SCL requires an external pull-up resistor to $V_{\text{DDIO}}$ .
SDA	8	Input/Output, Open Drain	Data line for the serial control bus communication SDA requires an external pull-up resistor to $V_{\text{DDIO}}$ .
MODE	12	Input, LVCMOS w/ pull down	$I^{2}C$ Mode select MODE = H,- <b>REQUIRED</b> . The MODE pin must be set HIGH to allow $I^{2}C$ configuration of the serializer.
ID[x]	9	Input, analog	Device ID Address Select Resistor to Ground and 10 k $\Omega$ pull-up to 1.8V rail. See Table 3
CONTROL AND	CONFIGURATION		
PDB	13	Input, LVCMOS w/ pull down	Power down Mode Input Pin. PDB = H, Serializer is enabled and is ON. PDB = L, Serailizer is in Power Down mode. When the Serializer is in Power Down, the PLL is shutdown, and IDD is minimized. Programmed control register data are NOT retained and reset to default values
RES	10, 11	Input, LVCMOS w/ pull down	Reserved. This pin MUST be tied LOW.
NC	22, 21, 20, 19		No Connect

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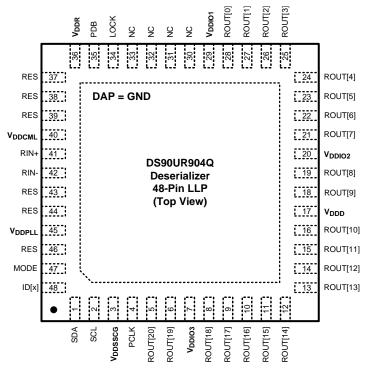
**NSTRUMENTS** 

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#### Pin Descriptions (continued)

Pin Name	Pin No.	I/O, Type	Description
FPD-LINK II INTEI	RFACE		
DOUT+	17	Output, CML	Non-inverting differential output. The interconnect must be AC Coupled with a 100 nF capacitor.
DOUT-	16	Output, CML	Inverting differential output. The interconnect must be AC Coupled with a 100 nF capacitor.
POWER AND GRO	OUND		
VDDPLL	14	Power, Analog	PLL Power, 1.8V ±5%
VDDT	15	Power, Analog	Tx Analog Power, 1.8V ±5%
VDDCML	18	Power, Analog	CML Power, 1.8V ±5%
VDDD	34	Power, Digital	Digital Power, 1.8V ±5%
VDDIO	31	Power, Digital	Power for I/O stage. The single-ended inputs and SDA, SCL are powered from $V_{DDIO}$ . $V_{DDIO}$ can be connected to a 1.8V ±5% or 3.3V ±10%
VSS	DAP	Ground, DAP	DAP must be grounded. DAP is the large metal contact at the bottom side, located at the center of the LLP package. Connected to the ground plane (GND) with at least 16 vias.

## DS90UR904Q Pin Diagram





### **DS90UR904Q** Deserializer Pin Descriptions

#### **Pin Descriptions**

Pin Name	Pin No.	I/O, Type	Description					
LVCMOS PARAI	LVCMOS PARALLEL INTERFACE							
ROUT[20:0]	5, 6, 8, 9, 10, 11, 12, 13, 14, 15, 16, 18, 19, 21, 22, 23, 24, 25, 26, 27, 28	Outputs, LVCMOS	Parallel data outputs.					

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# DS90UR903Q, DS90UR904Q

INSTRUMENTS

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# **Pin Descriptions (continued)**

Pin Name	Pin No.	I/O, Type	Description
PCLK	4	Output, LVCMOS	Pixel Clock Output Pin. Strobe edge set by RRFB control register.
SERIAL CONTR	OL BUS - I <sup>2</sup> C CO	MPATIBLE	
SCL	2	Input, Open Drain	Clock line for the serial control bus communication SCL requires an external pull-up resistor to V <sub>DDIO</sub> .
SDA	1	Input/Output, Open Drain	Data line for the serial control bus communication SDA requires an external pull-up resistor to $V_{\text{DDIO}}$ .
MODE	47	Input, LVCMOS w/ pull up	$I^2C$ Mode select MODE = H - <b>REQUIRED</b> . The MODE pin must be set HIGH to allow $I^2C$ configuration of the deserializer.
Input pin to select the Slave Device Address.			Device ID Address Select Resistor to Ground and 10 k $\Omega$ pull-up to 1.8V rail. See Table 4
Input is connect to external resistor divider to set programmable Device ID address	48	Input, analog	
CONTROL AND	CONFIGURATIO	N	
			Power down Mode Input Pin.
		Input, LVCMOS	PDB = H, Deserializer is enabled and is ON.
PDB	B 35		PDB = L, Deserializer is in Power Down mode. When the Deserializer is in Power Down. Programmed control register data are NOT retained and reset to default values.
			LOCK Status Output Pin.
LOCK	34	Output,	LOCK = H, PLL is Locked, outputs are active
		LVCMOS	LOCK = L, PLL is unlocked, ROUT and PCLK output states are controlled by OSS_SEL control register. May be used as Link Status.
			Reserved.
RES	37, 38, 39, 43, 44, 46	-	Pin 46: This pin MUST be tied LOW. Pin 37, 43, 44: Leave pin open.
			Pins 38, 39: Route to test point or leave open if unused.
NC	30, 31, 32, 33		No Connect
FPD-LINK II INTI	ERFACE		
RIN+	41	Input, CML	Noninverting differential input. The interconnect must be AC Coupled with a 100 nF capacitor.
RIN-	42	Inputt, CML	Inverting differential input. The interconnect must be AC Coupled with a 100 nF capacitor.
POWER AND GR	ROUND		
VDDSSCG	3	Power, Digital	SSCG Power, 1.8V $\pm$ 5% Power supply must be connected regardless if SSCG function is in operation.
VDDIO1/2/3	29, 20, 7	Power, Digital	LVCMOS I/O Buffer Power, The single-ended outputs and control input are powered from V <sub>DDIO</sub> . V <sub>DDIO</sub> can be connected to a 1.8V $\pm$ 5% or 3.3V $\pm$ 10%
VDDD	17	Power, Digital	Digital Core Power, 1.8V ±5%
VDDR	36	Power, Analog	Rx Analog Power, 1.8V ±5%
VDDCML	40	Power, Analog	1.8V ±5%
VDDPLL	45	Power, Analog	PLL Power, 1.8V ±5%
VSS	DAP	Ground, DAP	DAP must be grounded. DAP is the large metal contact at the bottom side, located at the center of the LLP package. Connected to the ground plane (GND) with at least 16 vias.

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RUMENTS



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## Absolute Maximum Ratings <sup>(1)</sup>

Supply Voltage – V <sub>DDn</sub> (1.8V)	-0.3V to +2.5V
Supply Voltage – V <sub>DDIO</sub>	-0.3V to +4.0V
LVCMOS Input Voltage I/O Voltage	-0.3V to + (VDDIO + 0.3V)
CML Driver I/O Voltage (V <sub>DD</sub> )	-0.3V to +(V <sub>DD</sub> + 0.3V)
CML Receiver I/O Voltage (V <sub>DD</sub> )	-0.3V to (V <sub>DD</sub> + 0.3V)
Junction Temperature	+150°C
Storage Temperature	-65°C to +150°C
Maximum Package Power Dissipation Capacity	1/θ <sub>JA</sub> °C/W above +25°
Package Derating: DS90UR903Q 40L LLP	
θ <sub>JA</sub> (based on 16 thermal vias)	30.7 °C/W
θ <sub>JC</sub> (based on 16 thermal vias)	6.8 °C/W
DS90UR904Q 48L LLP	
θ <sub>JA</sub> (based on 16 thermal vias)	26.9 °C/W
θ <sub>JC</sub> (based on 16 thermal vias)	4.4 °C/W
ESD Rating (IEC 61000-4-2)	R <sub>D</sub> = 330Ω, C <sub>S</sub> = 150pF
Air Discharge (DOUT+, DOUT-, RIN+, RIN-)	≥±25 kV
Contact Discharge (DOUT+, DOUT-, RIN+, RIN-)	≥±10 kV
ESD Rating (ISO10605)	R <sub>D</sub> = 330Ω, C <sub>S</sub> = 150/330pF
ESD Rating (ISO10605)	$R_{D} = 2K\Omega, C_{S} = 150/330pF$
Air Discharge (DOUT+, DOUT-, RIN+, RIN-)	≥±15 kV
Contact Discharge (DOUT+, DOUT-, RIN+, RIN-)	≥±10 kV
ESD Rating (HBM)	≥±8 kV
ESD Rating (CDM)	≥±1 kV
ESD Rating (MM)	≥±250 V

For soldering specifications: see product folder at www.national.com and www.national.com/ms/MS/MS-SOLDERING.pdf

(1) "Absolute Maximum Ratings" indicate limits beyond which damage to the device may occur, including inoperability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the Absolute Maximum Ratings or other conditions beyond those indicated in the Recommended Operating Conditions is not implied. The Recommended Operating Conditions indicate conditions at which the device is functional; the device should not be operated beyond such conditions.

# **Recommended Operating Conditions**

	Min	Nom	Max	Units
Supply Voltage (V <sub>DDn</sub> )	1.71	1.8	1.89	V
LVCMOS Supply Voltage (V <sub>DDIO</sub> ) OR	1.71	1.8	1.89	V
LVCMOS Supply Voltage (V <sub>DDIO</sub> )	3.0	3.3	3.6	V
Supply Noise				
V <sub>DDn</sub> (1.8V)			25	mVp-p
V <sub>DDIO</sub> (1.8V)			25	mVp-p
V <sub>DDIO</sub> (3.3V)			50	mVp-p
Operating Free Air Temperature (T <sub>A</sub> )	-40	+25	+105	°C
PCLK Clock Frequency	10		43	MHz



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# Electrical Characteristics (1) (2) (3)

Over recommended operating supply and temperature ranges unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
LVCMOS DC	SPECIFICATIONS 3.3V I/O (SER INPL	JTS, DES OUTPUTS, CONTROL IN	PUTS AND (	OUTPUTS)		
V <sub>IH</sub>	High Level Input Voltage	V <sub>IN</sub> = 3.0V to 3.6V	2.0		V <sub>IN</sub>	V
V <sub>IL</sub>	Low Level Input Voltage	V <sub>IN</sub> = 3.0V to 3.6V	GND		0.8	V
I <sub>IN</sub>	Input Current	$V_{IN} = 0V \text{ or } 3.6V$ $V_{IN} = 3.0V \text{ to } 3.6V$	-20	±1	+20	μA
V <sub>OH</sub>	High Level Output Voltage	$V_{DDIO} = 3.0V$ to 3.6V $I_{OH} = -4$ mA	2.4		V <sub>DDIO</sub>	V
V <sub>OL</sub>	Low Level Output Voltage	$V_{DDIO} = 3.0V$ to 3.6V $I_{OL} = +4$ mA	GND		0.4	V
l <sub>os</sub>	Output Short Circuit Current	V <sub>OUT</sub> = 0V		-39		mA
l <sub>oz</sub>	TRI-STATE® Output Current	PDB = 0V, V <sub>OUT</sub> = 0V or V <sub>DD</sub>	-20	±1	+20	μA
LVCMOS DC	SPECIFICATIONS 1.8V I/O (SER INPL	JTS, DES OUTPUTS, CONTROL IN	PUTS AND (	OUTPUTS)		
V <sub>IH</sub>	High Level Input Voltage	V <sub>IN</sub> = 1.71V to 1.89V	0.65 V <sub>IN</sub>		V <sub>IN</sub> +0.3	V
V <sub>IL</sub>	Low Level Input Voltage	V <sub>IN</sub> = 1.71V to 1.89V	GND		0.35 V <sub>IN</sub>	V
I <sub>IN</sub>	Input Current	V <sub>IN</sub> = 0V or 1.89V V <sub>IN</sub> = 1.71V to 1.89V	-20	±1	+20	μA
V <sub>OH</sub>	High Level Output Voltage	$V_{DDIO} = 1.71V$ to 1.89V $I_{OH} = -4$ mA	V <sub>DDIO</sub> - 0.45		V <sub>DDIO</sub>	V
V <sub>OL</sub>	Low Level Output Voltage	$V_{DDIO} = 1.71V$ to 1.89V $I_{OL} = +4$ mA	GND		0.45	V
l <sub>os</sub>	Output Short Circuit Current	$V_{OUT} = 0V$		-20		mA
I <sub>OZ</sub>	TRI-STATE® Output Current	$ \begin{array}{l} PDB = 0V, \\ V_{OUT} = 0V \text{ or } V_{DD} \end{array} $	-20	±1	+20	μA
	R DC SPECIFICATIONS (DOUT+, DOU	Г-)				
V <sub>OD</sub>	Output Differential Voltage	$R_T = 100\Omega$ (Figure 10)	268	340	412	mV
ΔV <sub>OD</sub>	Output Differential Voltage Unbalance	$R_{L} = 100\Omega$		1	50	mV
V <sub>OS</sub>	Output Differential Offset Voltage	R <sub>L</sub> = 100Ω (Figure 10)	V <sub>DD (MIN)</sub> - V <sub>OD (MAX)</sub>	V <sub>DD</sub> - V <sub>OD</sub>	V <sub>DD (MAX)</sub> - V <sub>OD (MIN)</sub>	V
ΔV <sub>OS</sub>	Offset Voltage Unbalance	$R_L = 100\Omega$		1	50	mV
l <sub>os</sub>	Output Short Circuit Current	DOUT+/- = 0V		-27		mA
R <sub>T</sub>	Differential Internal Termination Resistance	Differential across DOUT+ and DOUT-	80	100	120	Ω
	VER DC SPECIFICATIONS (RIN+, RIN-					
V <sub>TH</sub>	Differential Threshold High Voltage	(Figure 12)			+90	mV
V <sub>TL</sub>	Differential Threshold Low Voltage		-90			
V <sub>IN</sub>	Differential Input Voltage Range	RIN+ - RIN-	180			mV
I <sub>IN</sub>	Input Current	$V_{IN} = V_{DD}$ or 0V, $V_{DD} = 1.89V$	-20	±1	+20	μA
R <sub>T</sub>	Differential Internal Termination Resistance	Differential across RIN+ and RIN-	80	100	120	Ω

(1) The Electrical Characteristics tables list guaranteed specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.

(2) Current into device pins is defined as positive. Current out of a device pin is defined as negative. Voltages are referenced to ground except VOD, ΔVOD, VTH and VTL which are differential voltages.

(3) Typical values represent most likely parametric norms at 1.8V or 3.3V,  $T_A = +25^{\circ}C$ , and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.



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# Electrical Characteristics <sup>(1) (2) (3)</sup> (continued)

Over recommended operating supply and temperature ranges unless otherwise specified.

Symbol	Parameter		Conditions	Min	Тур	Max	Units
IDDT	Serializer (Tx) VDDn Supply Current (includes load current)	$\begin{array}{l} R_{T} = 100\Omega \\ WORST \\ CASE \\ pattern \\ (Figure 7) \end{array}$	VDDn = 1.89V PCLK = 43 MHz Default Registers		62	90	mA
		$R_T = 100\Omega$ RANDOM PRBS-7 pattern			55		
I <sub>DDIOT</sub>	Serializer (Tx) VDDIO Supply Current (includes load current)	$R_T = 100\Omega$ WORST CASE	VDDIO = 1.89V PCLK = 43 MHz Default Registers		2	5	mA
		pattern (Figure 7)	VDDIO = 3.6V PCLK = 43 MHz Default Registers		7	15	
DDTZ	Serializer (Tx) Supply Current	PDB = 0V;	V <sub>DDn</sub> = 1.89V		370	775	
I <sub>DDIOTZ</sub>	Power-down	All other LVCMOS	V <sub>DDIO</sub> = 1.89V		55	125	μA
		Inputs = 0V	V <sub>DDIO</sub> = 3.6V		65	135	- μΑ
I <sub>DDR</sub>	Deserializer (Rx) VDDn Supply Current (includes load current)	$V_{DDn} =$ 1.89V $C_L = 8 pF$ WORST CASE Pattern (Figure 7)	PCLK = 43 MHz SSCG[3:0] = ON Default Registers		60	96	
		$V_{DDn} =$ 1.89V $C_L = 8 pF$ RANDOM PRBS-7 Pattern	PCLK = 43 MHz Default Registers		53		
IDDIOR	Deserializer (Rx) VDDIO Supply Current (includes load current)	$V_{DDIO} = 1.89V$ $C_{L} = 8 \text{ pF}$ WORST CASE Pattern (Figure 7)	PCLK = 43 MHz Default Registers		21	32	mA
		$V_{DDIO} =$ 3.6V $C_L = 8 pF$ WORST CASE Pattern	PCLK = 43 MHz Default Registers		49	83	
I <sub>DDRZ</sub>	Deserializer (Rx) Supply Current	PDB = 0V;	V <sub>DDn</sub> = 1.89V		42	400	
I <sub>DDIORZ</sub>	Power-down	All other LVCMOS	V <sub>DDIO</sub> = 1.89V		8	40	μA
		Inputs = 0V	$V_{DDIO} = 3.6V$		350	800	μΛ



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## Electrical Characteristics <sup>(1)</sup> <sup>(2)</sup> <sup>(3)</sup> Recommended Serializer Timing for PCLK <sup>(4)</sup>

Over recommended operating supply and temperature ranges unless otherwise specified.

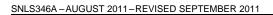
Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>TCP</sub>	Transmit Clock Period	10 MHz – 43 MHz	23.3	Т	100	ns
t <sub>TCIH</sub>	Transmit Clock Input High Time		0.4T	0.5T	0.6T	ns
t <sub>TCIL</sub>	Transmit Clock Input Low Time		0.4T	0.5T	0.6T	ns
t <sub>CLKT</sub>	PCLK Input Transition Time (Figure 13)		0.5		3	ns
f <sub>OSC</sub>	Internal oscillator clock source			25		MHz

(1) The Electrical Characteristics tables list guaranteed specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.

(2) Current into device pins is defined as positive. Current out of a device pin is defined as negative. Voltages are referenced to ground except VOD, ΔVOD, VTH and VTL which are differential voltages.

(3) Typical values represent most likely parametric norms at 1.8V or 3.3V,  $T_A = +25^{\circ}C$ , and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.

(4) Recommended Input Timing Requirements are input specifications and not tested in production.



## Electrical Characteristics <sup>(1)</sup> <sup>(2)</sup> <sup>(3)</sup> Serializer Switching Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
t <sub>LHT</sub>	CML Low-to-High Transition Time	$R_L = 100\Omega$ (Figure 8)		150	330	ps
t <sub>HLT</sub>	CML High-to-Low Transition Time	$R_L = 100\Omega$ (Figure 8)		150	330	ps
t <sub>DIS</sub>	Data Input Setup to PCLK	Serializer Data Inputs	2.0			ns
t <sub>DIH</sub>	Data Input Hold from PCLK	(Figure 14)	2.0			ns
t <sub>PLD</sub>	Serializer PLL Lock Time	$R_L = 100\Omega^{(4)}$ (5)		1	2	ms
t <sub>SD</sub>	Serializer Delay	$\label{eq:RT} \begin{array}{l} R_{T} = 100\Omega \\ PCLK = 10{-}43 \ MHz \\ Register \ 0x03h \ b[0] \ (TRFB = 1) \\ (Figure \ 16) \end{array}$	6.386T + 5	6.386T + 12	6.386T + 19.7	ns
t <sub>JIND</sub>	Serializer Output Deterministic Jitter	Serializer output intrinsic deterministic jitter . Measured (cycle-cycle) with PRBS-7 test pattern PCLK = 43 MHz (3) (6)		0.13		UI
t <sub>JINR</sub>	Serializer Output Random Jitter	Serializer output intrinsic random jitter (cycle-cycle). Alternating-1,0 pattern. PCLK = 43 MHz (3) (6)		0.04		UI
t <sub>JINT</sub>	Peak-to-peak Serializer Output Jitter	Serializer output peak-to-peak jitter includes deterministic jitter, random jitter, and jitter transfer from serializer input. Measured (cycle-cycle) with PRBS-7 test pattern. PCLK = 43 MHz <sup>(3)</sup> (6)		0.396		UI
$\lambda_{\text{STXBW}}$	Serializer Jitter Transfer Function -3 dB Bandwidth	PCLK = 43 MHz Default Registers (Figure 22) <sup>(3)</sup>		1.90		MHz
δ <sub>STX</sub>	Serializer Jitter Transfer Function (Peaking)	PCLK = 43 MHz Default Registers (Figure 22) <sup>(3)</sup>		0.944		dB
$\delta_{STXf}$	Serializer Jitter Transfer Function (Peaking Frequency)	PCLK = 43 MHz Default Registers (Figure 22) <sup>(3)</sup>		500		kHz

(1) The Electrical Characteristics tables list guaranteed specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.

(2) Current into device pins is defined as positive. Current out of a device pin is defined as negative. Voltages are referenced to ground except VOD, ΔVOD, VTH and VTL which are differential voltages.

(3) Typical values represent most likely parametric norms at 1.8V or 3.3V,  $T_A = +25^{\circ}C$ , and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.

(4) t<sub>PLD</sub> and t<sub>DDLT</sub> is the time required by the serializer and deserializer to obtain lock when exiting power-down state with an active PCLK
 (5) Specification is guaranteed by design.

(6) UI – Unit Interval is equivalent to one ideal serialized data bit width. The UI scales with PCLK frequency.

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## Electrical Characteristics <sup>(1) (2) (3)</sup> Deserializer Switching Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified.

Symbol	Parameter	Conditions	Pin/Freq.	Min	Тур	Max	Units
t <sub>RCP</sub>	Receiver Output Clock Period	$t_{RCP} = t_{TCP}$	PCLK	23.3	Т	100	ns
t <sub>PDC</sub>	PCLK Duty Cycle	Default Registers SSCG[3:0] = OFF	PCLK	45	50	55	%
t <sub>CLH</sub>	LVCMOS Low-to-High Transition Time	V <sub>DDIO</sub> : 1.71V to 1.89V or 3.0 to 3.6V,	PCLK	1.3	2.0	2.8	
t <sub>CHL</sub>	LVCMOS High-to-Low Transition Time	$C_L = 8 \text{ pF} (\text{lumped load})$ Default Registers ( <i>Figure 18</i> ) <sup>(4)</sup>		1.3	2.0	2.8	ns
t <sub>CLH</sub>	LVCMOS Low-to-High Transition Time	V <sub>DDIO</sub> : 1.71V to 1.89V or 3.0 to 3.6V,	Deserializer ROUTn Data Outputs	1.6	2.4	3.3	
t <sub>CHL</sub>	LVCMOS High-to-Low Transition Time	C <sub>L</sub> = 8 pF (lumped load) Default Registers ( <i>Figure 18</i> ) <sup>(4)</sup>	1.6	2.4	3.3	ns	
t <sub>ROS</sub>	ROUT Setup Data to PCLK	V <sub>DDIO</sub> : 1.71V to 1.89V or	Deserializer ROUTn	0.38T	0.5T		
t <sub>ROH</sub>	ROUT Hold Data to PCLK	3.0V to 3.6V, $C_L = 8 \text{ pF}$ (lumped load) Default Registers	Data Outputs	0.38T	0.5T		ns
t <sub>DD</sub>	Deserializer Delay	Default Registers Register 0x03h b[0] (RRFB = 1) (Figure 19)	10 MHz–43 MHz	4.571T + 8	4.571T + 12	4.571T + 16	ns
t <sub>DDLT</sub>	Deserializer Data Lock Time	(Figure 17) <sup>(5)</sup>	10 MHz-43 MHz			10	ms
t <sub>RJIT</sub>	Receiver Input Jitter Tolerance	(Figure 21, Figure 23) (6) (7)	43 MHz		0.53		UI
t <sub>RCJ</sub>	Receiver Clock Jitter	PCLK	10 MHz		300	550	
		SSCG[3:0] = OFF	43 MHz		120	250	ps
t <sub>DPJ</sub>	Deserializer Period Jitter	PCLK	10 MHz		425	600	
		SSCG[3:0] = OFF	43 MHz		320	480	ps
t <sub>DCCJ</sub>	Deserializer Cycle-to-Cycle Clock	PCLK	10 MHz		320	500	
	Jitter	SSCG[3:0] = OFF	43 MHz		300	500	ps
fdev	Spread Spectrum Clocking Deviation Frequency	LVCMOS Output Bus SSC[3:0] = ON	20 MHz-43 MHz		±0.5% to ±2.0%		%
fmod	Spread Spectrum Clocking Modulation Frequency	(Figure 24)	20 MHz-43 MHz		9 kHz to 66 kHz		kHz

(1) The Electrical Characteristics tables list guaranteed specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not guaranteed.

(2) Current into device pins is defined as positive. Current out of a device pin is defined as negative. Voltages are referenced to ground except VOD, ΔVOD, VTH and VTL which are differential voltages.

(3) Typical values represent most likely parametric norms at 1.8V or 3.3V,  $T_A = +25^{\circ}C$ , and at the Recommended Operation Conditions at the time of product characterization and are not guaranteed.

(4) Specification is guaranteed by characterization and is not tested in production.

(5) t<sub>PLD</sub> and t<sub>DDLT</sub> is the time required by the serializer and deserializer to obtain lock when exiting power-down state with an active PCLK

(6) UI – Unit Interval is equivalent to one ideal serialized data bit width. The UI scales with PCLK frequency.

(7) t<sub>RJIT</sub> max (0.61UI) is limited by instrumentation and actual t<sub>RJIT</sub> of in-band jitter at low frequency (<2 MHz) is greater 1 UI.

(8) t<sub>DCJ</sub> is the maximum amount of jitter measured over 30,000 samples based on Time Interval Error (TIE).

(9) t<sub>DPJ</sub> is the maximum amount the period is allowed to deviate measured over 30,000 samples.

(10) t<sub>DCCJ</sub> is the maximum amount of jitter between adjacent clock cycles measured over 30,000 samples.

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# Serial Control Bus AC Timing Specifications (SCL, SDA) - I<sup>2</sup>C Compliant (Figure 6)

Over recommended supply and temperature ranges unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
RECOMM	ENDED INPUT TIMING REQUIREMENTS	; (1)	I		1	1
f <sub>SCL</sub>	SCL Clock Frequency		>0		100	kHz
t <sub>LOW</sub>	SCL Low Period	f <sub>SCL</sub> = 100 kHz	4.7			μs
t <sub>HIGH</sub>	SCL High Period	_	4.0			μs
t <sub>HD:STA</sub>	Hold time for a start or a repeated start condition		4.0			μs
t <sub>SU:STA</sub>	Set Up time for a start or a repeated start condition	_	4.7			μs
t <sub>HD:DAT</sub>	Data Hold Time		0		3.45	μs
t <sub>SU:DAT</sub>	Data Set Up Time		250			ns
t <sub>SU:STO</sub>	Set Up Time for STOP Condition		4.0			μs
t <sub>r</sub>	SCL & SDA Rise Time				1000	ns
t <sub>f</sub>	SCL & SDA Fall Time				300	ns
C <sub>b</sub>	Capacitive load for bus				400	pF
SWITCHIN	IG CHARACTERISTICS <sup>(2)</sup>					
t <sub>HD:DAT</sub>	Data Hold Time		0		3.45	μs
t <sub>SU:DAT</sub>	Data Set Up Time		250			ns
t <sub>f</sub>	SCL & SDA Fall Time				300	ns

(1) Recommended Input Timing Requirements are input specifications and not tested in production.

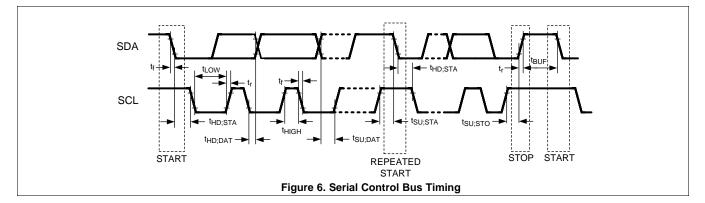
(2) Specification is guaranteed by design.

# DS90UR903Q, DS90UR904Q

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# Serial Control Bus DC Characteristics (SCL, SDA) - I<sup>2</sup>C Compliant

Over recommended supply and temperature ranges unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>IH</sub>	Input High Level	SDA and SCL	0.7 x V <sub>DDIO</sub>		V <sub>DDIO</sub>	V
V <sub>IL</sub>	Input Low Level Voltage	SDA and SCL	GND		0.3 x V <sub>DDIO</sub>	V
V <sub>HY</sub>	Input Hysteresis	SDA and SCL		>50		mV
I <sub>OZ</sub>	TRI-STATE Output Current	PDB = 0V V <sub>OUT</sub> = 0V or V <sub>DD</sub>	-20	±1	+20	μA
I <sub>IN</sub>	Input Current	SDA or SCL, Vin = $V_{DDIO}$ or GND	-20	±1	+20	μA
C <sub>IN</sub>	Input Pin Capacitance			<5		pF
V <sub>OL</sub>	Low Level Output Voltage	SCL and SDA $V_{DDIO} = 3.0V$ $I_{OL} = 1.5mA$			0.36	V
		$\begin{array}{l} \text{SCL and SDA} \\ \text{V}_{\text{DDIO}} = 1.71\text{V} \\ \text{I}_{\text{OL}} = 1\text{mA} \end{array}$			0.36	V

# **AC Timing Diagrams and Test Circuits**

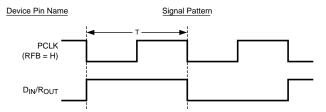
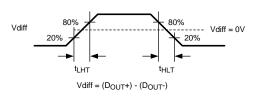
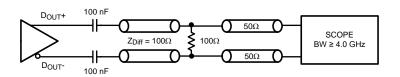
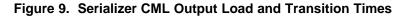


Figure 7. "Worst Case" Test Pattern









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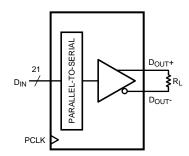


Figure 10. Serializer VOD DC Diagram

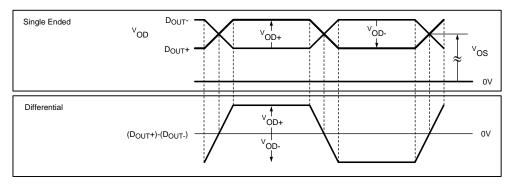


Figure 11. Serializer VOD DC Diagram

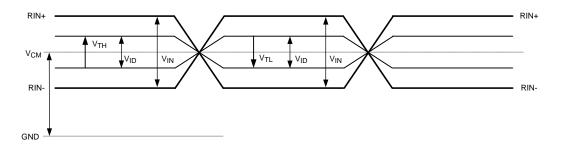


Figure 12. Differential VTH/VTL Definition Diagram

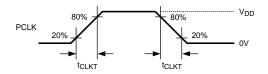


Figure 13. Serializer Input Clock Transition Times



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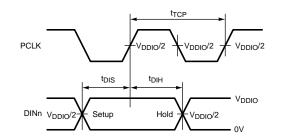


Figure 14. Serializer Setup/Hold Times

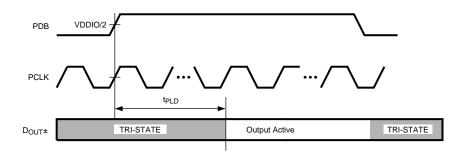
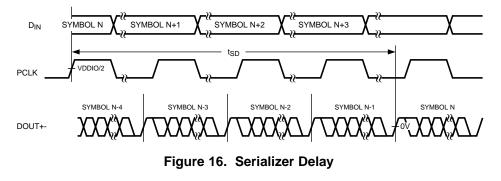


Figure 15. Serializer Data Lock Time



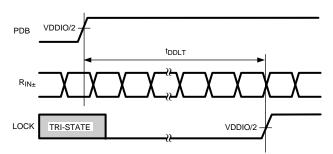


Figure 17. Deserializer Data Lock Time

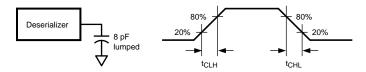


Figure 18. Deserializer LVCMOS Output Load and Transition Times

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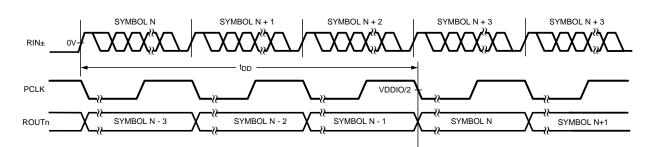


Figure 19. Deserializer Delay

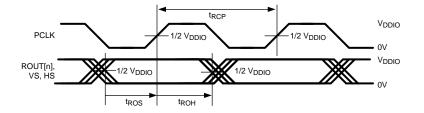
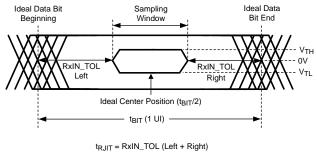
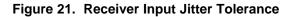


Figure 20. Deserializer Output Setup/Hold Times



Sampling Window = 1 UI - t<sub>RJIT</sub>



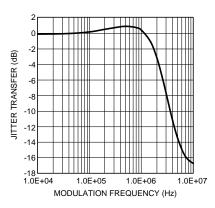


Figure 22. Typical Serializer Jitter Transfer Function Curve at 43 MHz

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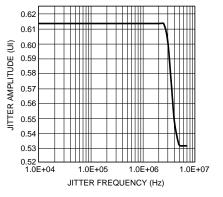
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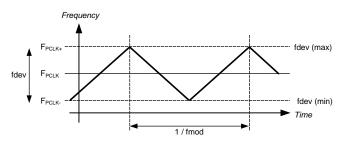


Figure 24.	Spread S	pectrum (	Clock Out	put Profile
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Addr									
(Hex)	Name	Bits	Field	R/W	Default	Description			
0	0 I <sup>2</sup> C Device ID		DEVICE ID	RW	0xB0'h	7-bit address of Serializer; 0x58'h (1011_000X'b) default			
0	I C Device ID	0	SER ID SEL	RVV.	0,001	0: Device ID is from ID[x] 1: Register I <sup>2</sup> C Device ID overrides ID[x]			
		7:3	RESERVED		0x00'h	Reserved			
		2	RESERVED	RW	0	Reserved			
1	Reset	1	DIGITAL RESET0	RW	0 self clear	1: Resets the device to default register values. Does not affect device I <sup>2</sup> C Bus or Device ID			
		0	DIGITAL RESET1	RW	0 self clear	1: Digital Reset, retains all register values			
2	Reserved	7:0	RESERVED		0x20'h	Reserved			



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Table 1.	DS90UR903Q	Control	Registers	(continued)
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Addr (Hex)	Name	Bits	Field	R/W	Default	Description
	Reserved	7:6	RESERVED		11'b	Reserved
	VDDIO Control	5	VDDIO CONTOL	RW	1	Auto V <sub>DDIO</sub> detect Allows manual setting of VDDIO by register. 0: Disable 1: Enable (auto detect mode)
	VDDIO Mode	4	VDDIO MODE	RW	1	VDDIO voltage set Only used when VDDIOCONTROL = 0 0: 1.8V 1: 3.3V
3	RESERVED	3	RESERVED	RW	1	Reserved
0	RESERVED	2	RESERVED		0	Reserved
	PCLK_AUTO	1	PCLK_AUTO	RW	1	Switch over to internal 25 MHz Oscillator clock in the absence of PCLK 0: Disable 1: Enable
	TRFB	0	TRFB	RW	1	Pixel Clock Edge Select: 0: Parallel Interface Data is strobed on the Falling Clock Edge. 1: Parallel Interface Data is strobed on the Rising Clock Edge.
4	Reserved	7:0	RESERVED		0x80'h	Reserved
5	Reserved	7:0	RESERVED	RW	0x40'h	Reserved
6	Reserved	7:0	RESERVED	RW	0xC0'h	Reserved
7	Reserved	7:0	RESERVED	RW	0x00'h	Reserved
8	Reserved	7:0	RESERVED		0x00'h	Reserved
9	Reserved	7:0	RESERVED		0x01'h	Reserved
А	Reserved	7:0	RESERVED		0x00'h	Reserved
В	Reserved	7:0	RESERVED		0x00'h	Reserved
	Reserved	7:3	RESERVED		0x00'h	Reserved
С	PCLK Detect	2	PCLK DETECT	R	0	1: Valid PCLK detected 0: Valid PCLK not detected
	Reserved	3	RESERVED		0	Reserved
	Reserved	0	RESERVED	R	0	Reserved
D	Reserved	7:0	RESERVED		0x11'h	Reserved
Е	Reserved	7:0	RESERVED		0x01'h	Reserved
F	Reserved	7:0	RESERVED		0x03'h	Reserved
10	Reserved	7:0	RESERVED		0x03'h	Reserved
11	Reserved	7:0	RESERVED		0x03'h	Reserved
12	Reserved	7:0	RESERVED		0x03'h	Reserved
			GPCR[7]			0: LOW
			GPCR[6]			1: HIGH
			GPCR[5]			
10	General Purpose	7.0	GPCR[4]		0x00'h	
13	Control Reg	7:0	GPCR[3]	RW	UXUU N	
			GPCR[2]			
			GPCR[1]			
			GPCR[0]			

Addr (Hex)	Name	Bits	Field	R/W	Default	Description
0	I <sup>2</sup> C Device ID	7:1	DEVICE ID	RW	0xC0'h	7-bit address of Deserializer; 0x60h (1100_000X) default
		0	DES ID SEL			0: Device ID is from ID[x] 1: Register I <sup>2</sup> C Device ID overrides ID[x]
		7:3	RESERVED		0x00'h	Reserved
		2	RESERVED	RW	0	Reserved
1	Reset	1	DIGITALRESET0	RW	0 self clear	1: Resets the device to default register values. Does not affect device I <sup>2</sup> C Bus or Device ID
		0	DIGITALRESET1	RW	0 self clear	1: Digital Reset, retains all register values
	RESERVED	7:6	RESERVED		00'b	Reserved
	Auto Clock	5	AUTO_CLOCK	RW	0	1: Output PCLK or Internal 25 MHz Oscillator clock 0: Only PCLK when valid PCLK present
	OSS Select	4	OSS_SEL			Output Sleep State Select 0: Outputs = TRI-STATE, when LOCK = L 1: Outputs = LOW , when LOCK = L
2	SSCG	3:0	SSCG		0000'Ь	SSCG Select 0000: Normal Operation, SSCG OFF (default) 0001: fmod (kHz) PCLK/2168, fdev ±0.50% 0010: fmod (kHz) PCLK/2168, fdev ±1.00% 0011: fmod (kHz) PCLK/2168, fdev ±1.50% 0100: fmod (kHz) PCLK/1300, fdev ±0.50% 0110: fmod (kHz) PCLK/1300, fdev ±0.50% 0111: fmod (kHz) PCLK/1300, fdev ±1.00% 0111: fmod (kHz) PCLK/1300, fdev ±1.50% 1000: fmod (kHz) PCLK/1300, fdev ±0.50% 1010: fmod (kHz) PCLK/868, fdev ±0.50% 1010: fmod (kHz) PCLK/868, fdev ±1.00% 1011: fmod (kHz) PCLK/868, fdev ±1.50% 1100: fmod (kHz) PCLK/868, fdev ±0.50% 1100: fmod (kHz) PCLK/650, fdev ±0.50% 1110: fmod (kHz) PCLK/650, fdev ±1.00% 1111: fmod (kHz) PCLK/650, fdev ±1.50%
	RESERVED	7:6	RESERVED		11'b	Reserved
	VDDIO Control	5	VDDIO CONTROL	RW	1	Auto voltage control 0: Disable 1: Enable (auto detect mode)
	VDDIO Mode	4	VDDIO MODE	RW	0	VDDIO voltage set 0: 1.8V 1: 3.3V
3	RESERVED	3	RESERVED	RW	1	Reserved
	RESERVED	2	RESERVED	RW	0	Reserved
	RESERVED	1	RESERVED		0	Reserved
	RRFB	0	RRFB	RW	1	Pixel Clock Edge Select 0: Parallel Interface Data is strobed on the Falling Clock Edge 1: Parallel Interface Data is strobed on the Rising Clock Edge.
4	EQ Control	7:0	EQ	RW	0x00'h	EQ Gain 00'h = ~0.0  dB 01'h = ~4.5  dB 03'h = ~6.5  dB 07'h = ~7.5  dB 0F'h = ~8.0  dB 1F'h = ~11.0  dB 3F'h = ~12.5  dB FF'h = ~14.0  dB

Table 2. DS90UR904Q Control Registers

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Addr (Hex)NameBitsFieldR/WDefaultE5RESERVED7:0RESERVED0x00'hReserved6RESERVED7RESERVED0Reserved6RESERVED6:4RESERVEDRW000'bReserved7RESERVED3:0RESERVEDRW1111'bReserved7RESERVED7:0RESERVEDRW0x80'hReserved8:17RESERVED7:0RESERVEDRW0x00'hReserved18RESERVED7:0RESERVED0x00'hReserved	Description
RESERVED7RESERVED0Reserved6RESERVED6:4RESERVEDRW000'bReservedRESERVED3:0RESERVEDRW1111'bReserved7RESERVED7:0RESERVEDRW0xB0'hReserved8:17RESERVED7:0RESERVEDRW0x00'hReserved	
6RESERVED6:4RESERVEDRW000'bReservedRESERVED3:0RESERVEDRW1111'bReserved7RESERVED7:0RESERVEDRW0xB0'hReserved8:17RESERVED7:0RESERVEDRW0x00'hReserved	
RESERVED3:0RESERVEDRW1111'bReserved7RESERVED7:0RESERVEDRW0xB0'hReserved8:17RESERVED7:0RESERVEDRW0x00'hReserved	
7RESERVED7:0RESERVEDRW0xB0'hReserved8:17RESERVED7:0RESERVEDRW0x00'hReserved	
8:17 RESERVED 7:0 RESERVED RW 0x00'h Reserved	
18   RESERVED   7:0   RESERVED   0x00'h   Reserved	
19 RESERVED 7:0 RESERVED 0x01'h Reserved	
1A RESERVED 7:0 RESERVED 0x00'h Reserved	
1B RESERVED 7:0 RESERVED 0x00'h Reserved	
RESERVED 7:3 RESERVED 0x00'h Reserved	
RESERVED 2 RESERVED 0 Reserved	
1C     Signal Detect Status     1     R     0     0: Active signal not detected 1: Active signal detected	
LOCK Pin Status     0     R     0     0: CDR/PLL Unlocked       1: CDR/PLL Locked	
1D Reserved 7:0 RESERVED 0x17'h Reserved	
1E Reserved 7:0 RESERVED 0x07'h Reserved	
1F Reserved 7:0 RESERVED 0x01'h Reserved	
20 Reserved 7:0 RESERVED 0x01'h Reserved	
21 Reserved 7:0 RESERVED 0x01'h Reserved	
22 Reserved 7:0 RESERVED 0x01'h Reserved	
23 General Purpose Control Reg 7:0 GPCR[6] GPCR[5] GPCR[4] GPCR[3] GPCR[2] GPCR[1] GPCR[0] RW 0x00'h	
24 RESERVED 0 RESERVED RW 0 Reserved	
25 RESERVED 7:0 RESERVED R 0x00'h Reserved	
7:6 RESERVED RW 00'b Reserved	
26 RESERVED 5:0 RESERVED RW 0 Reserved	

# Table 2. DS90UR904Q Control Registers (continued)

### **Functional Description**

The DS90UR903Q/904Q FPD-Link II chipset is intended for video display applications. The Serializer/ Deserializer chipset operates from a 10 MHz to 43 MHz pixel clock frequency. The DS90UR903Q transforms a 21-bit wide parallel LVCMOS data bus into a single high-speed differential pair. The high-speed serial bit stream contains an embedded clock and DC-balance information which enhances signal quality to support AC coupling. The DS90UR904Q receives the single serial data stream and converts it back into a 21-bit wide parallel data bus.

### DISPLAY APPLICATION

The DS90UR903Q/904Q chipset is intended for interface between a host (graphics processor) and a Display. It supports a 21 bit parallel video bus for 18-bit color depth (RGB666) display format. In a RGB666 configuration, 18 color bits (R[5:0], G[5:0], B[5:0]), Pixel Clock (PCLK) and three control bits (VS, HS and DE) are supported across the serial link.

The DS90UR903Q Serializer accepts a 21-bit parallel data bus. The parallel data is converted into a single differential link. The DS90UR904Q Deserializer extracts the clock/control information from the incoming data stream and reconstructs the 21-bit parallel data.



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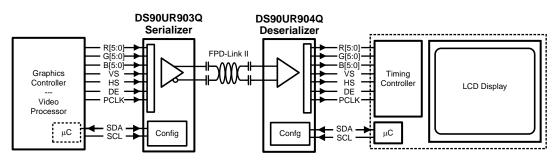


Figure 25. Typical Display System Diagram

### **CAMERA APPLICATION**

Camera applications are also supported by the DS90UR903Q/904Q chipset. The host controller/processsor is connected to the deserializer, while the CMOS image sensor provides data to the serializer.

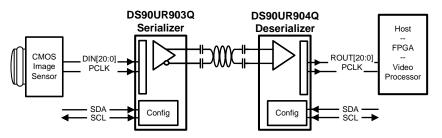


Figure 26. Typical Camera System Diagram

### SERIAL FRAME FORMAT

The DS90UR903Q/904Q chipset will transmit and receive a pixel of data in the following format:

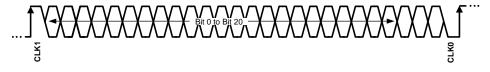


Figure 27. Serial Bitstream for 28-bit Symbol

The High Speed Serial Channel is a 28-bit symbol composed of 21 bits of data containing video data & control information transmitted from Serializer to Deserializer. CLK1 and CLK0 represent the embedded clock in the serial stream. CLK1 is always HIGH and CLK0 is always LOW. This data payload is optimized for signal transmission over an AC coupled link. Data is randomized, balanced and scrambled.

#### **DESCRIPTION OF SERIAL CONTROL BUS**

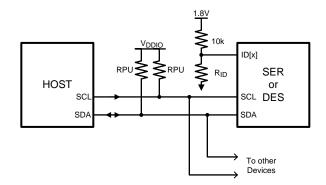
### ID[X] ADDRESS DECODER

The ID[x] pin is used to decode and set the physical slave address of the Serializer/Deserializer (I<sup>2</sup>C only) to allow up to six devices on the bus using only a single pin. The pin sets one of six possible addresses for each Serializer/Deserializer device. The pin must be pulled to VDD (1.8V, NOT VDDIO)) with a 10 k $\Omega$  resistor and a pull down resistor (RID) of the recommended value to set the physical device address. The recommended maximum resistor tolerance is 0.1% worst case (0.2% total tolerance).

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#### Table 3. ID[x] Resistor Value – DS90UR903Q

	ID[x] Resistor Value - DS90UR903Q Ser									
Resistor RID $\Omega$ (±0.1%)	Address 7'b	Address 8'b 0 appended (WRITE)								
0 GND	7b' 101 1000 (h'58)	8b' 1011 0000 (h'B0)								
2.0k	7b' 101 1001 (h'59)	8b' 1011 0010 (h'B2)								
4.7k	7b' 101 1010 (h'5A)	8b' 1011 0100 (h'B4)								
8.2k	7b' 101 1011 (h'5B)	8b' 1011 0110 (h'B6)								
12.1k	7b' 101 1100 (h'5C)	8b' 1011 1000 (h'B8)								
39.0k	7b' 101 1110 (h'5E)	8b' 1011 1100 (h'BC)								

(1) Specification is guaranteed by design.

#### Table 4. ID[x] Resistor Value – DS90UR904Q

ID[x] Resistor Value - DS90UR904Q Des								
Resistor RID Ω (±0.1%)	Address 7'b	Address 8'b 0 appended (WRITE)						
0 GND	7b' 110 0000 (h'60)	8b' 1100 0000 (h'C0)						
2.0k	7b' 110 0001 (h'61)	8b' 1100 0010 (h'C2)						
4.7k	7b' 110 0010 (h'62)	8b' 1100 0100 (h'C4)						
8.2k	7b' 110 0011 (h'63)	8b' 1101 0110 (h'C6)						
12.1k	7b' 110 0100 (h'64)	8b' 1101 1000 (h'C8)						
39.0k	7b' 110 0110 (h'66)	8b' 1100 1100 (h'CC)						

(1) Specification is guaranteed by design.

#### PROGRAMMABLE CONTROLLER

An integrated I<sup>2</sup>C slave controller is embedded in each of the DS90UR903Q Serializer and DS90UR904Q Deserializer. It must be used to access and program the extra features embedded within the configuration registers. Refer to Table 1 and Table 2 for details of control registers.

#### LVCMOS VDDIO OPTION

1.8V or 3.3V SER Inputs and DES Outputs are user selectable to provide compatibility with 1.8V and 3.3V system interfaces.



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#### POWERDOWN

The SER has a PDB input pin to ENABLE or Powerdown the device. The modes can be controlled by the host and is used to disable the Link to save power when the remote device is not operational. An auto mode is also available. In this mode, the PDB pin is tied High and the SER switches over to an internal oscillator when the PCLK stops or not present. When a PCLK starts again, the SER will then lock to the valid input PCLK and transmits the data to the DES. In powerdown mode, the high-speed driver outputs are static (High).

The DES has a PDB input pin to ENABLE or Powerdown the device. This pin can be controlled by the system and is used to disable the DES to save power. An auto mode is also available. In this mode, the PDB pin is tied High and the DES will enter powerdown when the serial stream stops. When the serial stream starts up again, the DES will lock to the input stream and assert the LOCK pin and output valid data. In powerdown mode, the Data and PCLK outputs are set by the OSS\_SEL control register.

#### POWER UP REQUIREMENTS AND PDB PIN

It is required to delay and release the PDB input signal after VDD (VDDn and VDDIO) power supplies have settled to the recommended operating voltages. A external RC network can be connected to the PDB pin to ensure PDB arrives after all the VDD have stabilized.

#### SIGNAL QUALITY ENHANCERS

#### **Des - Receiver Input Equalization (EQ)**

The receiver inputs provided input equalization filter in order to compensate for loss from the media. The level of equalization is controlled via register setting.

#### **EMI REDUCTION**

#### Des - Receiver Staggered Output

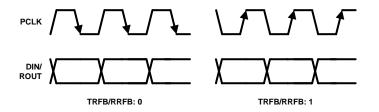
The Receiver staggered outputs allows for outputs to switch in a random distribution of transitions within a defined window. Outputs transitions are distributed randomly. This minimizes the number of outputs switching simultaneously and helps to reduce supply noise. In addition it spreads the noise spectrum out reducing overall EMI.

#### Des Spread Spectrum Clocking

The DS90UR904Q parallel data and clock outputs have programmable SSCG ranges from 9 kHz–66 kHz and  $\pm 0.5\% - \pm 2\%$  from 20 MHz to 43 MHz. The modulation rate and modulation frequency variation of output spread is controlled through the SSC control registers.

## PIXEL CLOCK EDGE SELECT (TRFB/RRFB)

The TRFB/RRFB selects which edge of the Pixel Clock is used. For the SER, this register determines the edge that the data is latched on. If TRFB register is 1, data is latched on the Rising edge of the PCLK. If TRFB register is 0, data is latched on the Falling edge of the PCLK. For the DES, this register determines the edge that the data is strobed on. If RRFB register is 1, data is strobed on the Rising edge of the PCLK. If RRFB register is 0, data is strobed on the Falling edge of the PCLK.







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#### **Applications Information**

## AC COUPLING

The SER/DES supports only AC-coupled interconnects through an integrated DC balanced decoding scheme. External AC coupling capacitors must be placed in series in the FPD-Link II signal path as illustrated in Figure 30.



Figure 30. AC-Coupled Connection

For high-speed FPD-Link II transmissions, the smallest available package should be used for the AC coupling capacitor. This will help minimize degradation of signal quality due to package parasitics. The I/O's require a 100 nF AC coupling capacitors to the line.

#### TYPICAL APPLICATION CONNECTION

Figure 31 shows a typical connection of the DS90UR903Q Serializer.

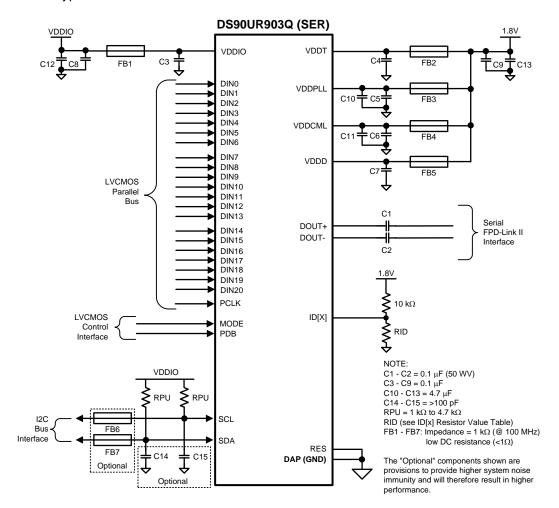
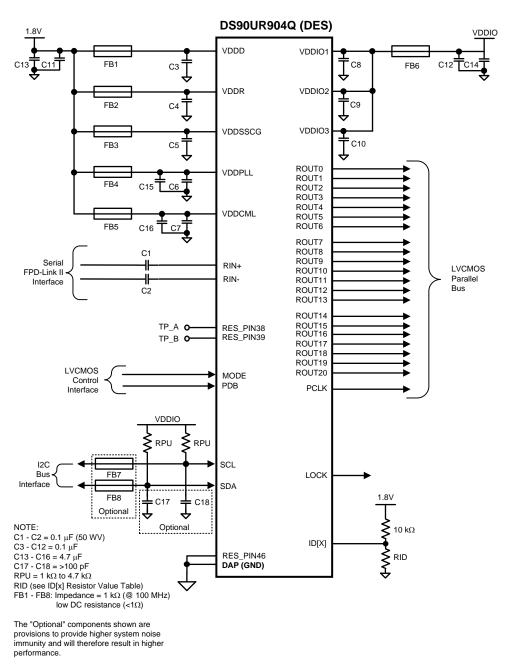




Figure 32 shows a typical connection of the DS90UR904Q Deserializer.

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#### **TRANSMISSION MEDIA**

The Ser/Des chipset is intended to be used over a wide variety of balanced cables depending on distance and signal quality requirements. The Ser/Des employ internal termination providing a clean signaling environment. The interconnect for FPD-Link II interface should present a differential impedance of 100 Ohms. Use of cables and connectors that have matched differential impedance will minimize impedance discontinuities. Shielded or un-shielded cables may be used depending upon the noise environment and application requirements. The chipset's optimum cable drive performance is achieved at 43 MHz at 10 meters length. The maximum signaling rate increases as the cable length decreases. Therefore, the chipset supports 50 MHz at shorter distances. Other cable parameters that may limit the cable's performance boundaries are: cable attenuation, near-end crosstalk and pair-to-pair skew.

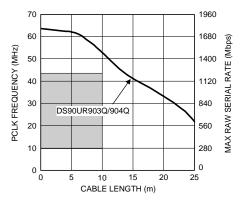


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For obtaining optimal performance, we recommend:

- Use Shielded Twisted Pair (STP) cable
- 100Ω differential impedance and 24 AWG (or lower AWG) cable
- Low skew, impedance matched
- Ground and/or terminate unused conductors

Figure 33 shows the Typical Performance Characteristics demonstrating various lengths and data rates using Rosenberger HSD and Leoni DACAR 538 Cable.



\*Note: Equalization is enabled for cable lengths greater than 7 meters

#### Figure 33. Rosenberger HSD & Leoni DACAR 538 Cable Performance

#### PCB LAYOUT AND POWER SYSTEM CONSIDERATIONS

Circuit board layout and stack-up for the Ser/Des devices should be designed to provide low-noise power feed to the device. Good layout practice will also separate high frequency or high-level inputs and outputs to minimize unwanted stray noise pickup, feedback and interference. Power system performance may be greatly improved by using thin dielectrics (2 to 4 mils) for power / ground sandwiches. This arrangement provides plane capacitance for the PCB power system with low-inductance parasitics, which has proven especially effective at high frequencies, and makes the value and placement of external bypass capacitors less critical. External bypass capacitors should include both RF ceramic and tantalum electrolytic types. RF capacitors may use values in the range of 0.01 uF to 0.1 uF. Tantalum capacitors may be in the 2.2 uF to 10 uF range. Voltage rating of the tantalum capacitors should be at least 5X the power supply voltage being used.

Surface mount capacitors are recommended due to their smaller parasitics. When using multiple capacitors per supply pin, locate the smaller value closer to the pin. A large bulk capacitor is recommend at the point of power entry. This is typically in the 50uF to 100uF range and will smooth low frequency switching noise. It is recommended to connect power and ground pins directly to the power and ground planes with bypass capacitors connected to the plane with via on both ends of the capacitor. Connecting power or ground pins to an external bypass capacitor will increase the inductance of the path.

A small body size X7R chip capacitor, such as 0603, is recommended for external bypass. Its small body size reduces the parasitic inductance of the capacitor. The user must pay attention to the resonance frequency of these external bypass capacitors, usually in the range of 20-30 MHz. To provide effective bypassing, multiple capacitors are often used to achieve low impedance between the supply rails over the frequency of interest. At high frequency, it is also a common practice to use two vias from power and ground pins to the planes, reducing the impedance at high frequency.

Some devices provide separate power for different portions of the circuit. This is done to isolate switching noise effects between different sections of the circuit. Separate planes on the PCB are typically not required. Pin Description tables typically provide guidance on which circuit blocks are connected to which power pin pairs. In some cases, an external filter many be used to provide clean power to sensitive circuits such as PLLs.



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Use at least a four layer board with a power and ground plane. Locate LVCMOS signals away from the differential lines to prevent coupling from the LVCMOS lines to the differential lines. Closely-coupled differential lines of 100 Ohms are typically recommended for differential interconnect. The closely coupled lines help to ensure that coupled noise will appear as common-mode and thus is rejected by the receivers. The tightly coupled lines will also radiate less.

Information on the LLP style package is provided in National Application Note: AN-1187.

## INTERCONNECT GUIDELINES

See AN-1108 and AN-905 for full details.

- Use 100Ω coupled differential pairs
- Use the S/2S/3S rule in spacings
  - - S = space between the pair
  - -2S = space between pairs
  - - 3S = space to LVCMOS signal
- Minimize the number of Vias
- Use differential connectors when operating above 500Mbps line speed
- Maintain balance of the traces
- Minimize skew within the pair

Additional general guidance can be found in the LVDS Owner's Manual - available in PDF format from the National web site at: www.national.com/lvds



# **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	0	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Samples
	(1)		Drawing			(2)		(3)	(Requires Login)
DS90UR903QSQ/NOPB	ACTIVE	WQFN	RTA	40	1000	Green (RoHS & no Sb/Br)	SN	Level-3-260C-168 HR	
DS90UR903QSQE/NOPB	ACTIVE	WQFN	RTA	40	250	Green (RoHS & no Sb/Br)	SN	Level-3-260C-168 HR	
DS90UR903QSQX/NOPB	ACTIVE	WQFN	RTA	40	2500	Green (RoHS & no Sb/Br)	SN	Level-3-260C-168 HR	
DS90UR904QSQ/NOPB	ACTIVE	WQFN	RHS	48	1000	Green (RoHS & no Sb/Br)	CU SN	Level-3-260C-168 HR	
DS90UR904QSQE/NOPB	ACTIVE	WQFN	RHS	48	250	Green (RoHS & no Sb/Br)	CU SN	Level-3-260C-168 HR	
DS90UR904QSQX/NOPB	ACTIVE	WQFN	RHS	48	2500	Green (RoHS & no Sb/Br)	CU SN	Level-3-260C-168 HR	

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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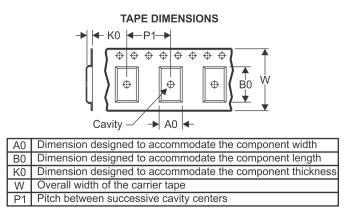
# PACKAGE MATERIALS INFORMATION

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# TAPE AND REEL INFORMATION





# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



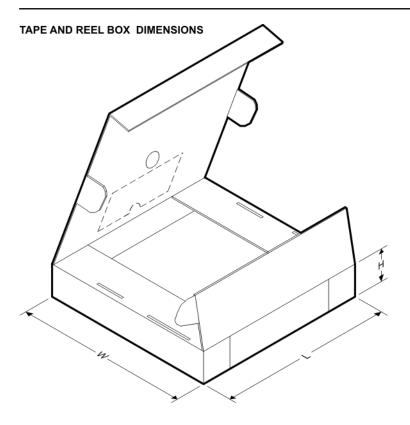
*All dimensions are nominal												
Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS90UR903QSQ/NOPB	WQFN	RTA	40	1000	330.0	16.4	6.3	6.3	1.5	12.0	16.0	Q1
DS90UR903QSQE/NOPB	WQFN	RTA	40	250	178.0	16.4	6.3	6.3	1.5	12.0	16.0	Q1
DS90UR903QSQX/NOPB	WQFN	RTA	40	2500	330.0	16.4	6.3	6.3	1.5	12.0	16.0	Q1
DS90UR904QSQ/NOPB	WQFN	RHS	48	1000	330.0	16.4	7.3	7.3	1.3	12.0	16.0	Q1
DS90UR904QSQE/NOPB	WQFN	RHS	48	250	178.0	16.4	7.3	7.3	1.3	12.0	16.0	Q1
DS90UR904QSQX/NOPB	WQFN	RHS	48	2500	330.0	16.4	7.3	7.3	1.3	12.0	16.0	Q1

TEXAS INSTRUMENTS

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# PACKAGE MATERIALS INFORMATION

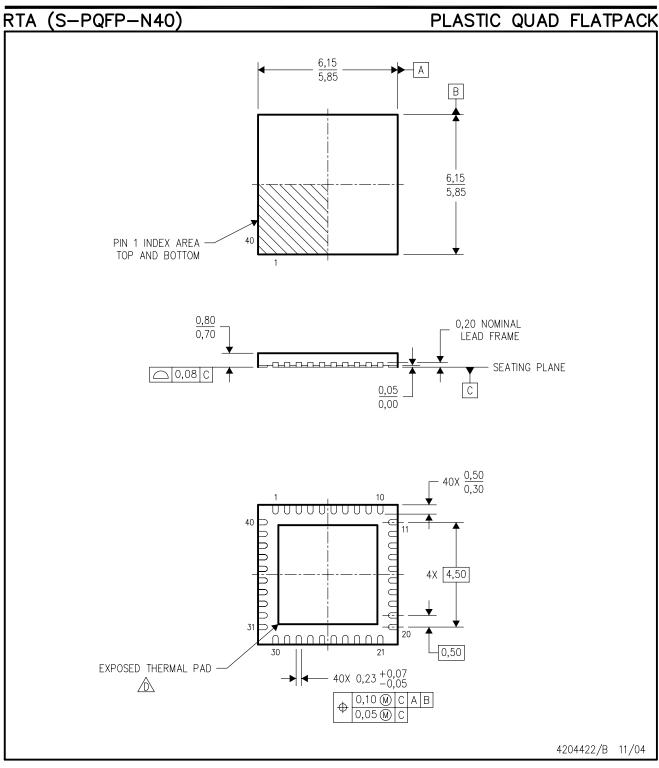
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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS90UR903QSQ/NOPB	WQFN	RTA	40	1000	358.0	343.0	63.0
DS90UR903QSQE/NOPB	WQFN	RTA	40	250	203.0	190.0	41.0
DS90UR903QSQX/NOPB	WQFN	RTA	40	2500	358.0	343.0	63.0
DS90UR904QSQ/NOPB	WQFN	RHS	48	1000	358.0	343.0	63.0
DS90UR904QSQE/NOPB	WQFN	RHS	48	250	203.0	190.0	41.0
DS90UR904QSQX/NOPB	WQFN	RHS	48	2500	358.0	343.0	63.0

# **MECHANICAL DATA**



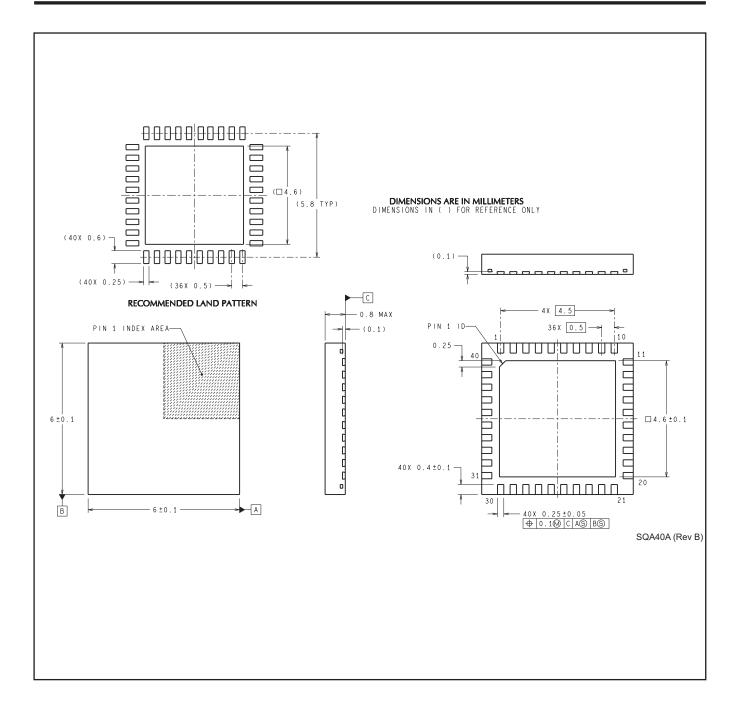
NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) Package configuration.
- A The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.



# **MECHANICAL DATA**

# RTA0040A





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